Sheet 1 of 1.

FORM PTO-1449				Docket Number (Optional) Application Number					
				31020787 US-02	Not yet assigned				
INFORMATION DISCLOSURE CITATION				Applicant					
	IN AN APPLICA	TION	Verspecht						
				Filing Date	g Date Group Art Unit				
(Use several sheets if necessary)				herewith]	Not yet assigned			
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EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP §609; Draw line through									
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